ON Semiconductor

Is Now

Onsemi

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Self-Protected Low Side Driver with In-Rush Current Management

NCV8412, NCV8412D

The NCV8412 is a three terminal protected Low–Side Smart Discrete FET. The protection features include Delta Thermal Shutdown, overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. The device also offers fault indication via the gate pin. This device is suitable for harsh automotive environments.

Features

- Short-Circuit Protection with In-Rush Current Management
- Delta Thermal Shutdown
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Overvoltage Protection and Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Grade 1 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive/Industrial

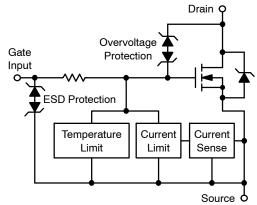


Figure 1. Block Diagram



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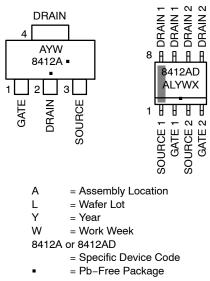
| V _{DSS} (Clamped) | R _{DS(ON)} TYP | I _D MAX (Limited) | | |
|-------------------------------|-------------------------|---------------------------------|--|--|
| 42 V | 145 m Ω @ 10 V | 5.9 A | | |





SOT-223 (TO-261) CASE 318E

SOIC-8 NB CASE 751



MARKING DIAGRAM

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information on page 13 of this data sheet.

MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|---|---|------------------------|--------|
| Drain-to-Source Voltage Internally Clamped | V _{DSS} | 42 | V |
| Drain-to-Gate Voltage Internally Clamped | V _{DG} | 42 | V |
| Gate-to-Source Voltage | V _{GS} | ±14 | V |
| Drain Current – Continuous | I _D | Internally L | imited |
| Total Power Dissipation (SOT-223)@ $T_A = 25^{\circ}C$ (Note 1) @ $T_A = 25^{\circ}C$ (Note 2) | P _D | 1.28 2.19 | W |
| Power Dissipation per Channel (SOIC–8 Dual), both channels loaded equally (@ $T_A = 25^{\circ}C$ (Note 1) (@ $T_A = 25^{\circ}C$ (Note 2) | PD | 0.57 0.78 | W |
| Total Power Dissipation (SOIC–8 Dual), only one channel loaded $@T_A = 25^{\circ}C$ (Note 1) $@T_A = 25^{\circ}C$ (Note 2) | PD | 0.93 1.20 | W |
| Thermal Resistance (SOT-223) Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2) Junction-to-Case (Soldering Point) | $f{R}_{	heta JA} \ f{R}_{	heta JA} \ f{R}_{	heta JA} \ f{R}_{	heta JS}$ | 97.0 57.0 7.9 | °C/W |
| Thermal Resistance (SOIC-8 Dual), both channels loaded equally Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2) Junction-to-Case (Soldering Point) | $f{R}_{	heta JA} \ f{R}_{	heta JA} \ f{R}_{	heta JA} \ f{R}_{	heta JS}$ | 107.8 79.4 29.0 | °C/W |
| Thermal Resistance (SOIC-8 Dual), only one channel loaded Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2) Junction-to-Case (Soldering Point) | $f{R}_{	heta JA} \ f{R}_{	heta JA} \ f{R}_{	heta JA} \ f{R}_{	heta JS}$ | 133.6 103.8 29.1 | °C/W |
| Single Pulse Inductive Load Switching Energy (L = 50 mH, I_{Lpeak} = 2 A, V_{GS} = 5 V, R_G = 25 Ω , T_{Jstart} = 25°C) | E _{AS} | 100 | mJ |
| Load Dump Voltage $(V_{GS} = 0 \text{ and } 10 \text{ V}, \text{ R}_{L} = 22 \Omega)$ (Note 3) | U _S * | 55 | V |
| Operating Junction Temperature | TJ | -40 to 150 | °C |
| Storage Temperature | T _{storage} | -55 to 150 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Mounted onto a 80 x 80 x 1.6 mm single layer FR4 board (100 sq mm, 1 oz. Cu, steady state)

 Mounted onto a 80 x 80 x 1.6 mm single layer FR4 board (645 sq mm, 1 oz. Cu, steady state)
Load Dump Test B (with centralized load dump suppression) according to ISO16750–2 standard. Guaranteed by design. Not tested in production. Passed Class C according to ISO16750-1.

ESD ELECTRICAL CHARACTERISTICS (Notes 4, 5)

| Parameter | Test Condition | Symbol | Min | Тур | Max | Unit |
|-------------------------------------|----------------------------|--------|------|-----|-----|------|
| Electro-Static Discharge Capability | Human Body Model (HBM) | ESD | 4000 | | | V |
| | Charged Device Model (CDM) | | 1000 | | | |

4. Not tested in production.

5. This device series incorporates ESD protection and is tested by the following methods:

ESD Human Body Model tested per AEC-Q100-002 (JS-001-2017)

Field Induced Charge Device Model ESD characterization is not performed on plastic molded packages with body sizes smaller than 2 x 2 mm due to the inability of a small package body to acquire and retain enough charge to meet the minimum CDM discharge current waveform characteristic defined in JEDEC JS-002-2018.

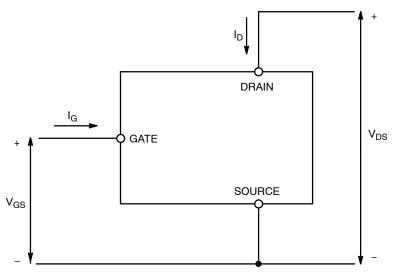


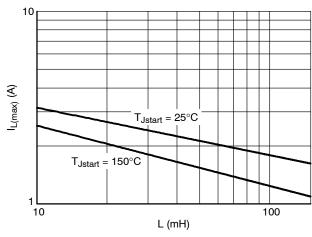
Figure 2. Voltage and Current Convention

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

| Parameter | Test Condition | Symbol | Min | Тур | Max | Unit |
|--|---|-------------------------------------|------|------|------|-------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-to-Source Clamped Breakdown | $V_{GS} = 0 V, I_D = 10 mA$ | V _{(BR)DSS} | 42 | 44 | 49 | V |
| Voltage | V_{GS} = 0 V, I _D = 10 mA, T _J = 150°C (Note 6) | | 39 | 42 | 49 |] |
| Zero Gate Voltage Drain Current | V_{GS} = 0 V, V_{DS} = 32 V | I _{DSS} | | 0.7 | 4.0 | μA |
| | V_{GS} = 0 V, V_{DS} = 32 V, T_{J} = 150°C (Note 6) | | | 2.3 | 20 | |
| Gate Input Current | $V_{GS} = 5 V, V_{DS} = 0 V$ | I _{GSS} | | 52 | 72 | μΑ |
| ON CHARACTERISTICS | | | | | | |
| Gate Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 150 \ \mu A$ | V _{GS(th)} | 1.0 | 1.6 | 2.2 | V |
| Gate Threshold Temperature Coefficient | $V_{GS} = V_{DS}$, $I_{D} = 150 \ \mu A$ (Note 6) | V _{GS(th)} /T _J | | 3.1 | | mV/°C |
| Static Drain-to-Source On Resistance | V _{GS} = 10 V, I _D = 1.7 A | R _{DS(ON)} | | 145 | 200 | mΩ |
| | V_{GS} = 10 V, I _D = 1.7 A, T _J = 150°C (Note 6) | | | 255 | 400 | |
| | V _{GS} = 5.0 V, I _D = 1.7 A | | | 180 | 230 | - |
| | V _{GS} = 5.0 V, I _D = 1.7 A, T _J = 150°C (Note 6) | | | 310 | 460 | |
| | V _{GS} = 5.0 V, I _D = 0.5 A | | | 180 | 230 | |
| | $V_{GS} = 5.0 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}, \text{ T}_{J} = 150^{\circ}\text{C}$ (Note 6) | | | 305 | 460 | |
| Source-to-Drain Forward On Voltage | $I_{\rm S}$ = 7 A, $V_{\rm GS}$ = 0 V | V _{SD} | | 0.95 | 1.2 | V |
| SWITCHING CHARACTERISTICS (Note | 6) | | | | | |
| Turn–On Time (10% V_{GS} to 90% $I_{D})$ | | t _{ON} | | 20 | 31 | μs |
| Turn–On Rise Time (10% I_D to 90% I_D) | | t _{rise} | | 14 | 25 | μs |
| Turn–Off Time (90% V_{GS} to 10% I_D) | V _{GS} = 0 V to 10 V, V _{DD} = 12 V, I _D = 1 A | t _{OFF} | | 96 | 140 | μs |
| Turn–Off Fall Time (90% I_D to 10% I_D) | | t _{fall} | | 37 | 50 | μs |
| Slew Rate On (80% V_{DS} to 50% $V_{DS})$ | | -dV _{DS} /dt _{ON} | 0.45 | 1.0 | | V/µs |
| Slew Rate Off (50% V_{DS} to 80% $V_{DS})$ | | dV _{DS} /dt _{OFF} | 0.3 | 0.4 | | V/µs |
| SELF PROTECTION CHARACTERISTIC | S | | | | | |
| Current Limit | V_{DS} = 10 V, V_{GS} = 5.0 V | I _{LIM} | 3.3 | 4.4 | 5.6 | А |
| | V _{DS} = 10 V, V _{GS} = 5.0 V, T _J = 150°C (Note 6) | | 3.3 | 4.0 | 4.9 | |
| | V _{DS} = 10 V, V _{GS} = 10 V (Note 6) | | 2.6 | 3.9 | 5.9 | |
| | V_{DS} = 10 V, V_{GS} = 10 V, T_{J} = 150°C (Note 6) | | 2.3 | 3.5 | 5.0 | |
| Temperature Limit (Turn-Off) | $V_{1} = (5.0) V (Noto 6)$ | T _{LIM(OFF)} | 150 | 175 | 190 | °C |
| Thermal Hysteresis | V _{GS} = 5.0 V (Note 6) | $\Delta T_{LIM(ON)}$ | | 15 | | |
| Temperature Limit (Turn-Off) | V _{GS} = 10 V (Note 6) | T _{LIM(OFF)} | 150 | 185 | 200 | |
| Thermal Hysteresis | $v_{\rm GS} = 10$ V (NOLE 0) | $\Delta T_{LIM(ON)}$ | | 15 | | |
| GATE INPUT CHARACTERISTICS (Note | 6) | | | | | |
| Device ON Gate Input Current | V_{GS} = 5 V, V_{DS} = 10 V, I_{D} = 1 A | I _{GON} | 25 | 52 | 72 | μA |
| | V_{GS} = 10 V, V_{DS} = 10 V, I_{D} = 1 A | | 250 | 333 | 480 | |
| Current Limit Gate Input Current | V_{GS} = 5 V, V_{DS} = 10 V | I _{GCL} | 35 | 65 | 96 | |
| | V _{GS} = 10 V, V _{DS} = 10 V | | 200 | 390 | 540 | |
| Thermal Limit Gate Input Current | V_{GS} = 5 V, V_{DS} = 10 V, I_{D} = 0 A | I _{GTL} | 550 | 630 | 750 | |
| | $V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 10 \text{ V}, \text{ I}_{D} = 0 \text{ A}$ | | 1350 | 1500 | 1650 | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.6. Not tested in production.

TYPICAL PERFORMANCE CURVES





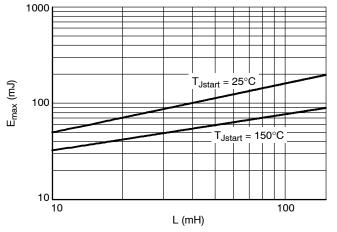
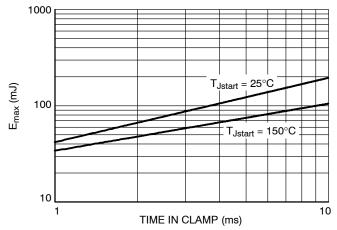
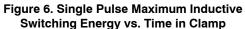


Figure 4. Single Pulse Maximum Switching Energy vs. Load Inductance





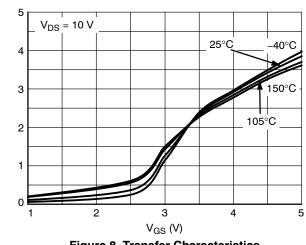


Figure 8. Transfer Characteristics

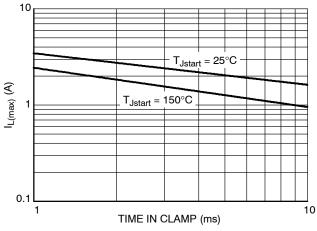


Figure 5. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

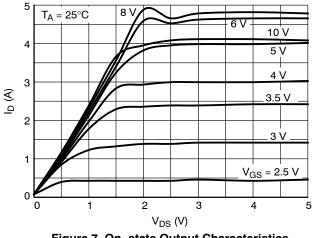
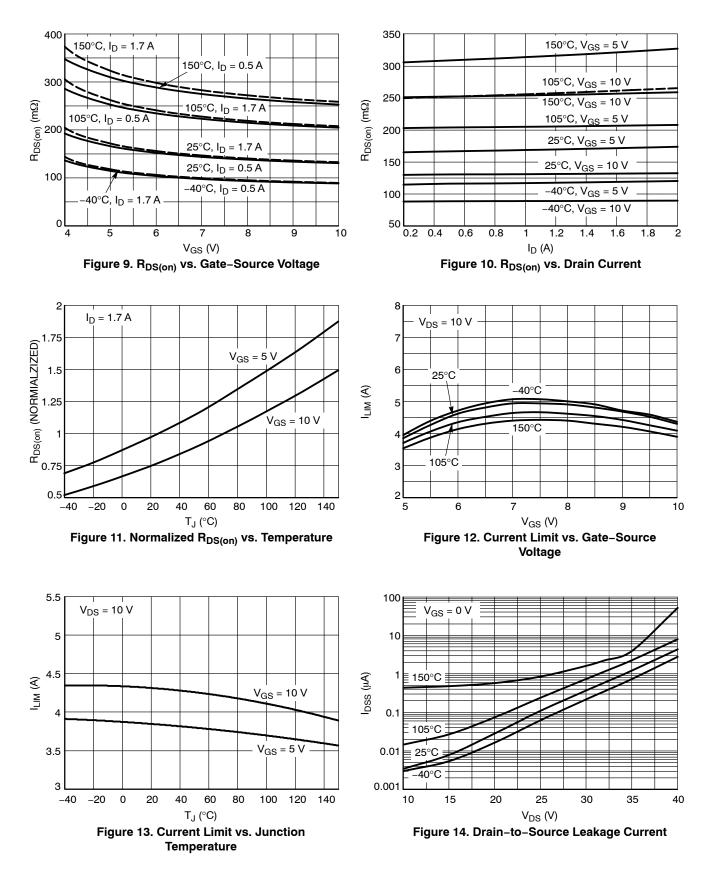
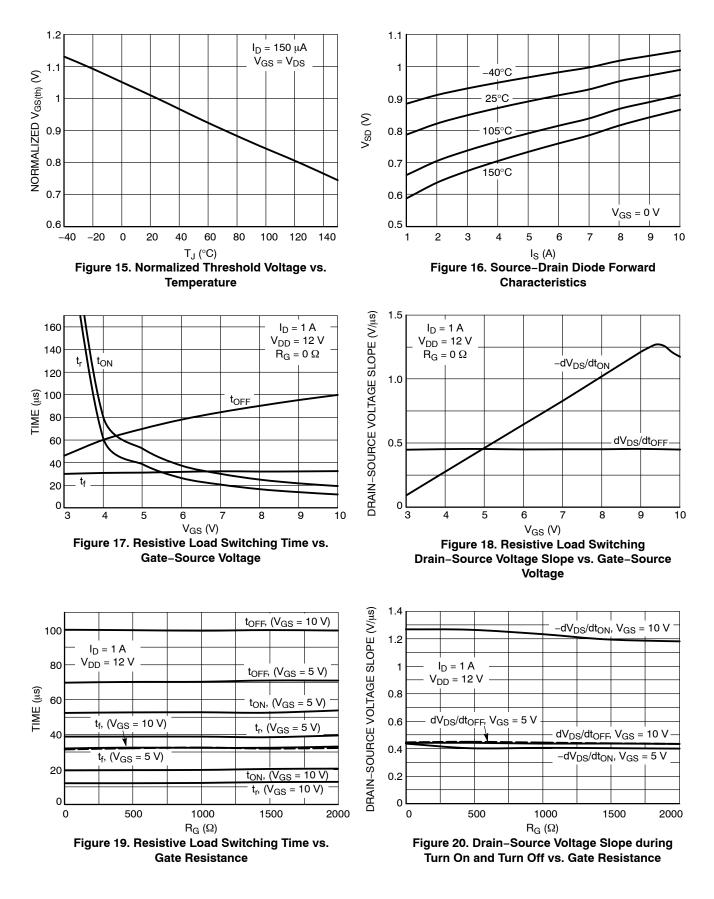


Figure 7. On-state Output Characteristics

I_D (A)





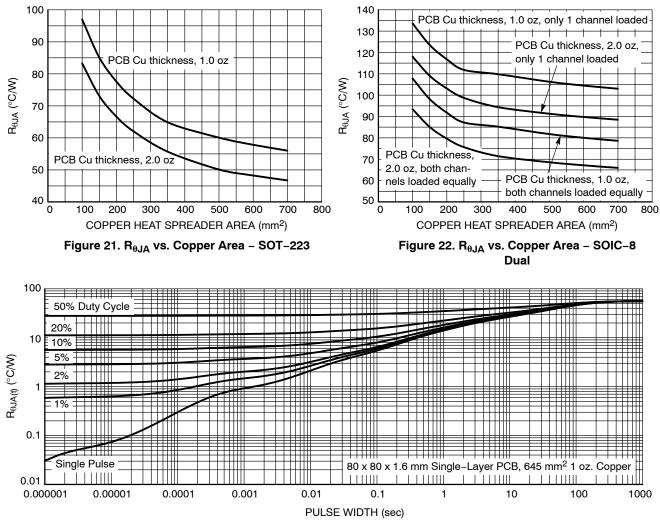


Figure 23. Transient Thermal Resistance - SOT-223

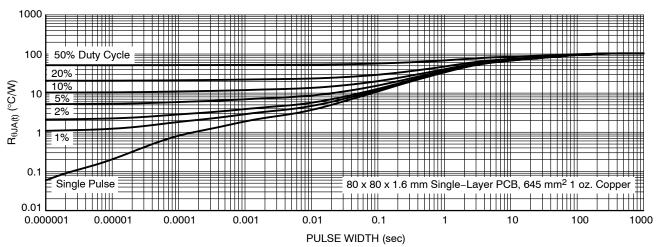


Figure 24. Transient Thermal Resistance - SOIC-8 Dual, only 1 channel loaded

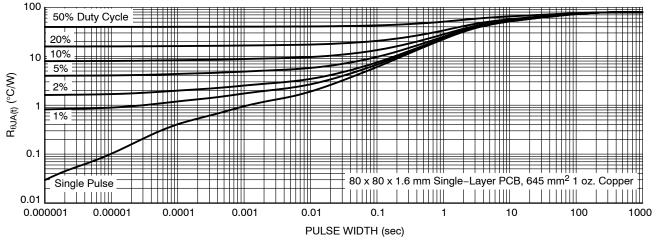


Figure 25. Transient Thermal Resistance – SOIC–8 Dual, both channels loaded equally

APPLICATION INFORMATION

Circuit Protection Features

The NCV8412 has three main protections. Current Limit, Thermal Shutdown and Delta Thermal Shutdown. These protections establish robustness of the NCV8412.

Current Limit and Short Circuit Protection

The NCV8412 has current sense element. In the event that the drain current reaches designed current limit level, integrated Current Limit protection establishes its constant level.

Delta Thermal Shutdown

Delta Thermal Shutdown (DTSD) Protection increases higher reliability of the NCV8412. DTSD consist of two independent temperature sensors – cold and hot sensors. The NCV8412 establishes a slow junction temperature rise by sensing the difference between the hot and cold sensors. ON/OFF output cycling is designed with hysteresis that results in a controlled saw tooth temperature profile (Figure 27). The die temperature slowly rises (DTSD) until the absolute temperature shutdown (TSD) is reached around 175°C.

Thermal Shutdown with Automatic Restart

Internal Thermal Shutdown (TSD) circuitry is provided to protect the NCV8412 in the event that the maximum

junction temperature is exceeded. When activated at typically 175°C, the NCV8412 turns off. This feature is provided to prevent failures from accidental overheating.

EMC Performance

If better EMC performance is needed, connect a small ceramic capacitor to the drain pin as close to the device as possible according to Figure 26.

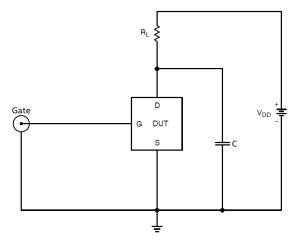
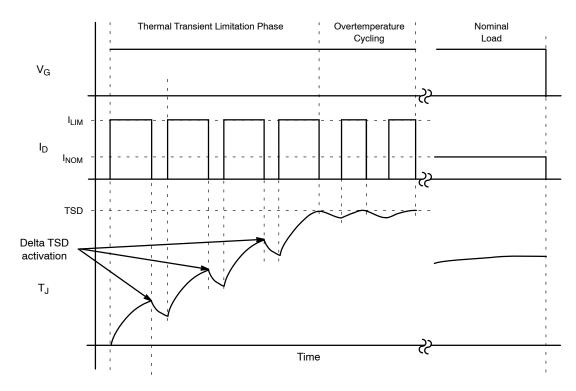
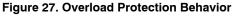


Figure 26. EMC Capacitor Placement



TEST CIRCUITS AND WAVEFORMS



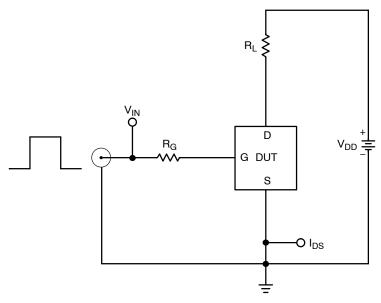


Figure 28. Resistive Load Switching Test Circuit

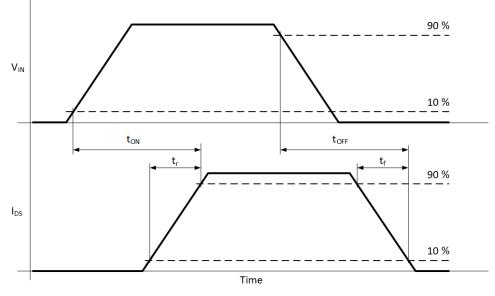


Figure 29. Resistive Load Switching Waveforms

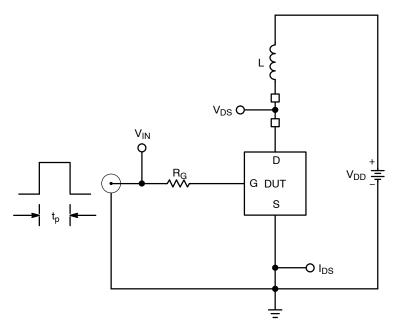


Figure 30. Inductive Load Switching Test Circuit

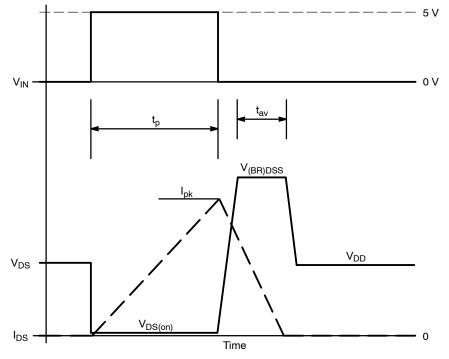


Figure 31. Inductive Load Switching Waveforms

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|---------------|---------|----------------------|-----------------------|
| NCV8412ASTT1G | 8412A | SOT-223 (Pb-Free) | 1,000 / Tape & Reel |
| NCV8412ASTT3G | 8412A | SOT-223 (Pb-Free) | 1,000 / Tape & Reel |
| NCV8412ADDR2G | 8412AD | SOIC-8 (Pb-Free) | 2,500 / Tape & Reel |

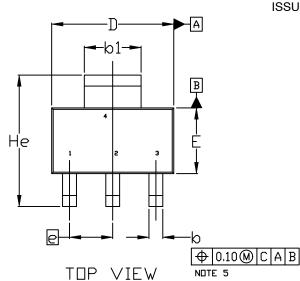
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SOT-223 (TO-261) CASE 318E-04 ISSUE R

SEE DETAIL A

FRONT VIEW

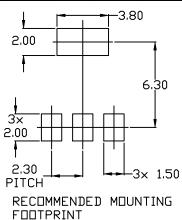


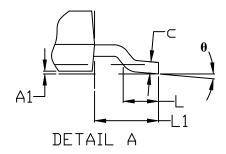
Α

NDTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. AI IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST PDINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

| | MILLIMETERS | | | |
|-----|-------------|------|------|--|
| DIM | MIN. | NDM. | MAX. | |
| A | 1.50 | 1.63 | 1.75 | |
| A1 | 0.02 | 0.06 | 0.10 | |
| b | 0.60 | 0.75 | 0.89 | |
| b1 | 2.90 | 3.06 | 3.20 | |
| с | 0.24 | 0.29 | 0.35 | |
| D | 6.30 | 6.50 | 6.70 | |
| E | 3.30 | 3.50 | 3.70 | |
| e | 2.30 BSC | | | |
| L | 0.20 | | | |
| L1 | 1.50 | 1.75 | 2.00 | |
| He | 6.70 | 7.00 | 7.30 | |
| θ | 0* | | 10* | |



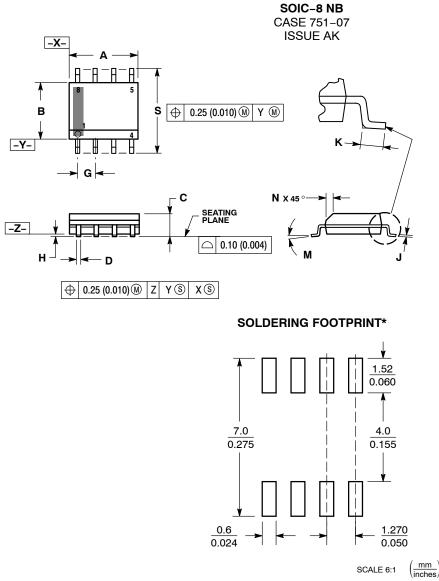


SIDE VIEW

н

0.10 C

PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER 1. ANSI Y14 5M 1982
- CONTROLLING DIMENSION: MILLIMETER. З. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) 4. PER SIDE
- PER SIDE. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT 5.
- MAXIMUM MATERIAL CONDITION. 751–01 THRU 751–06 ARE OBSOLETE. NEW 6. STANDARD IS 751-07.

| | MILL IN | ETEDE | INCHES | | |
|-----|------------------------|-------|-----------|-------|--|
| DIM | MILLIMETERS MIN MAX | | MIN | MAX | |
| Α | 4.80 | 5.00 | 0.189 | 0.197 | |
| В | 3.80 | 4.00 | 0.150 | 0.157 | |
| С | 1.35 | 1.75 | 0.053 | 0.069 | |
| D | 0.33 0.51 | | 0.013 | 0.020 | |
| G | 1.27 BSC | | 0.050 BSC | | |
| Н | 0.10 | 0.25 | 0.004 | 0.010 | |
| ſ | 0.19 | 0.25 | 0.007 | 0.010 | |
| к | 0.40 | 1.27 | 0.016 | 0.050 | |
| М | 0 ° 8 ° | | 0 ° | 8 ° | |
| Ν | 0.25 | 0.50 | 0.010 | 0.020 | |
| S | 5.80 | 6.20 | 0.228 | 0.244 | |

STYLE 11:

SOURCE 1 PIN 1. 2 GATE 1

- SOURCE 2 З.
- GATE 2 4.

DRAIN 2 DRAIN 2 5. 6.

- 7. DRAIN 1
- 8 DRAIN 1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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